

HARRIS HPL™-82C139

Programmable Chip Select Decoder (PCSD™)

Features Memory or I/O Chip Select Decoding, Replaces 2-3 ICs • Similar to Industry Standard 74139

- Architecture Optimized for "Bootstrap Decoding"
- Microprocessor Bus Oriented Interface Harris Advanced Scaled SAJI IV CMOS Process
- Faster than Low-Power Schottky at CMOS Power Consumption
- 16-Pin Ceramic Dual-in-Line Package
- Wide Temperature Ranges: (0°C to +75°C) (-40°C to +85°C) (-55°C to +125°C)
- Simple Programming Algorithm
- Mask Programmable for Volume Users

Pinout TOP VIEW □ vcc 15 70 LB 14 | TI ΗВ 13 7 YZ G1 🗀 G2 [12 T 73 11 MATCH G3 10 ALE G4 GND П SEL

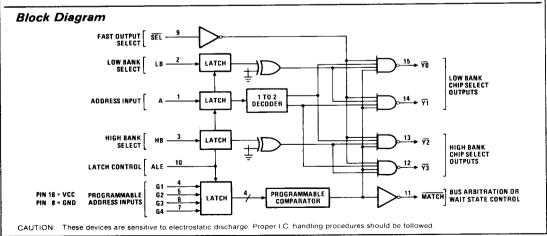
Description

The HPL-82C139 is a high performance Programmable Chip Select Decoder (PCSD) which is intended to be used for both memory and I/O chip select decoder applications. Utilizing the Harris advanced scaled SAJI IV CMOS process, this circuit provides bipolar speed with CMOS power consumption.

In a typical application, this circuit can replace two to three 74HCXX SSI/MSI ICs. The associated reductions in hoard area, chip count and power consumption result in a substantial increase in system reliability and an attendant decrease in system cost. A speed improvement of a factor of three to four over an equivalent implementation with 74HCXX logic is also realized. The fast decode provided by the 82C139 can result in improved system performance or a dramatic reduction in total system cost since less expensive, slower memories and I/O devices can be used. The HPL-82C139 is ideal for 16-bit microprocessor applications as a "bootstrap" PROM decoder or other memory and I/O decoder applications where four or fewer devices require selection within a section of address space.

The four "GX" inputs are field programmable for either high or low true address decoding. The Harris fuse link technology used in this product provides a permanent fuse with stable storage characteristics over the full temperature ranges of 00 to +750C, -400C to +850C. and -55°C to +125°C.

Transparent latches are utilized on all address inputs which permits the 82C139 to be used with both multiplexed and non-multiplexed address/data bus microprocessors.



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Specifications HPL-82C139

Absolute Maximum Ratings

Supply Voltage		+7.0 Volte
Input, Output or I/O Voltage Applied		GND -0.3V to VCC +0.3V
Storage Temperature Range		-650C to +1500C
Maximum Package Power Dissipation		1 Wat
θ _{[C}	15°C/W (CERDIP Package)	TBDOC/W (Plastic DIP Package)
$ heta_{ja}$	75°C/W (CERDIP Package).	TBD9C/W (Plastic DIP Package
Gate Count		500 Gates
Junction Temperature		+15090
Lead Temperature (Soldering, Ten Second	s)	+27500
CAUTION: Stresses above those listed in the "At is a stress only rating and operation of the device	solute Maximum Ratings" may caus	se permanent damage to the device. This

Operating Conditions

Operating Voltage Range	+4.5V to +5.5V
Operating Temperature Range	4.00 to 0.30
HPL-82C139-5	0°C to +70°C
HPL-82C139-9	-40°C to +85°C
HPL-82C139-8	-55°C to +125°C

D.C. Electrical Specifications (Operating)

sections of this specification is not implied.

HPL-82C139-5 (VCC = $5.0V \pm 10\%$, TA = 0° C to +75°C) HPL-82C139-9 (VCC = $5.0V \pm 10\%$, TA = -40°C to +85°C) HPL-82C139-8 (VCC = $5.0V \pm 10\%$, TA = -55°C to +125°C)

SYMBOL	PARAMETER		MIN	MAX	UNITS	TEST CONDITIONS
IIH IIL	Dedicated Input Current	"1" "0"		+1 -1	μΑ μΑ	VIH = VCC MAX VIL = 0V, VCC = VCC MAX
VIH VIL	Input Threshold Voltage	"1" "1" "0"	2.0 2.2	0.8	V	VCC = VCC MAX HPL-82C139-5/-9 VCC = VCC MAX HPL-82C139-8 VCC = VCC MIN
VOH1 VOH2 VOL	Output Voltage Output Voltage	"1" "1" "0"	3.0 VCC-0.4	0.4	V	IOH1 = -5mA IOH2 = -1mA VCC MIN, VIL MAX, VIH MIN IOL = +5mA
ICCSB*	Standby Power Supply Current			50	μΑ	VIH = VCC MAX IF = 0.0µA, VCC = VCC MAX
ICCOP*	Operating Power Supply Current			2	mA/MHz	VI = VCC or GND IF = 0.0µA, VCC = VCC MAX

ICCSB, ICCOP specifications are achieved only after complete programming of the device. These specifications are sampled and guaranteed but not 100% tested. While testing these specifications, output pins should be left open circuit.

A.C. Switching Specifications (Operating)

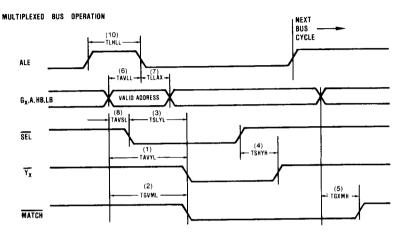
HPL-82C139-5 (VCC = $5.0V \pm 10\%$, TA = 0° C to +75°C) HPL-82C139-9 (VCC = $5.0V \pm 10\%$, TA = -40°C to +85°C) HPL-82C139-8 (VCC = $5.0V \pm 10\%$, TA = -55°C to +125°C)

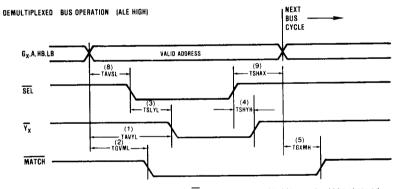
		HPL-82C139-5		HPL-82	2C139-9	HPL-82C139-8		
SYMBOL	PARAMETER	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
(1) TAVYL	Propagation delay A, LB, HB, or G to Output Low	_	50	-	50		50	ns
(2) TGVML	Propagation delay G to Match Output Low	-	50	-	50		50	ns
(3) TSLYL	Select Access Time to Output Low		35		35		35	ns
(4) TSHYH	H Select Access Time to Output High		35	_	35	_	35	ns
(5) TGXMH	Match De-Select Propagation Delay	_	50		50		50	ns
(6) TAVLL	Address Set-Up to ALE Trailing Edge	15	_	15		15		ns
(7) TLLAX	Address Hold From ALE Trailing Edge	15	_	15	_	15	_	ns
(8) TAVSL	Address Set-Up to SEL Low (Glitch-Free Operation)	15	_	15	_	15	_	ns
(9) TSHAX	Address Hold From SEL High (Glitch-Free Operation)	15	_	15		15	_	ns
(10)TLHLL	ALE Pulse Width	15		15		15		ns

Capacitance	TA = + 25°C (NOTE: Sampled and guaranteed - but not	: 100% tested.)
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SYMBOL	PARAMETER	MAX	UNITS	TEST CONDITIONS
CI	Input Capacitance	5	pF	VI = VCC or GND, f = 1 MHz
со	Output Capacitance	10	pF	VO = VCC or GND, f = 1 MHz

Switching Time Definitions





NOTES: 1. In order to ensure glitch-free operation of the $\overline{\text{Yx}}$ outputs, set-up and hold times should be observed

- 2. The SEL input controls the Yx outputs only and has no effect on the MATCH output.
- 3. AC switching characteristics are measured with inputs switching between GND and 3.0V t_r , t_f 5ns (10%-90%)

A.C. Test Load



Programming

Following is the programming procedure which is used for the HPL-82C139 programmable logic device. This device is manufactured with all fuses intact. Any desired fuse can be programmed by following the simple procedure shown on the following page. One may build a pro-

grammer to satisfy the specifications described in the table, or use any of the commercially available programmers which meets these specifications. Please contact Harris for a list of approved programmers.

Programming Specifications

TABLE 1.

SYMBOL PARAMETER			LIMITS			
STWIBUL	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
VCCP	VCC Voltage During Programming		11.50	12.00	12.00	V
VCCV	VCC Voltage During Verify		4.75	5.00	5.25	V
ICCP	ICC Limit During Programming		_	100	200	mA
VNEG	Edit Enable & Mode Select Voltage		-6.00	-6.00	-7.00	V
INEG	Edit Enable & Mode Select Current		_	_	-5.00	mA
VIL VIHV VIHP	Input Voltage Low Input Voltage High Input Voltage High	verify ① programming ①	0.00 VCCV-2 VCCP-2	0.00 VCCV VCCP	0.80 VCCV VCCP	V V
IILP IIHV IIHP	Input Current Low Input Current High Input Current High	VIL = 0.0V verify programming	_ _ _	0 0 0	1 1 1	μΑ μΑ μΑ
PWP TD rr1 rr2 f1 f2	Programming Width Pulse Seq. Delay Signal Rise Time VCC Rise Time Signal Fall Time VCC Fall Time	10% to 90% 10% to 90% 90% to 10% 90% to 10%	4.5 1 0.01 0.01 0.01 0.01	5.0 1 0.1 0.1 0.1 0.1	5.5 1 5 1 5	msec µsec µsec µsec µsec µsec
PP L	Programming Period Fuse Attempts/Link		 1	5.1 1	2	msec cycles

① Inputs defined as logic "1" (VIHV or VIHP) must track the VCC power supply when the supply is raised or lowered. The input levels should never exceed the level on the VCC Pin.

PGM ☐	1		Ɗ vcc
LBC	2	15	□ NC
нв⊏	3	14	□ NC
G1 🗖	4	13	□ NC
G2 🗖	5	12	□ NC
G3 ☐	6	11) NC
G4□	7	10	ALE
GND ☐	8	9] SEL

NOTE: While programming the CMOS HPL device, no input pins should be left floating. Output pins (11-15) should be left unconnected. It is suggested that a 0.1µF capacitor be placed between VCC and GND to minimize VCC voltage spikes.

FIGURE 1. HPL-82C139 EDIT MODE PINOUT

Programming Procedure

Set Up

- a. During programming or operation, no input pins should be left floating.
- No input pin voltage should ever be greater than the voltage applied to the device VCC pin.
- c. The device should be decoupled with a 0.1µF or greater capacitor located at the device socket and placed between the VCC and GND pins.

Power up:

- a. Initially, all input pins including power supply pins should be at ground potential.
- b. Normally, the input pins (pins 2-7, 9, 10) are driven with an open collector driver with a pull-up resistor to the VCC pin (pin 16) so that these inputs automatically track the voltage on the VCC pin when they are set to the high state. This prevents the voltage level on the input pins from exceeding the voltage applied to the VCC pin.
- c. Ramp the VCC pin (pin 16) to VCCV and the input pins (pins 2-7, 9, 10) to VIHV.

Programming Sequence

- a. After a delay TD, the programming mode is entered by taking the programming enable pin (pin 1) to VNEG. Pin 1 must remain at VNEG throughout the entire programming sequence.
- b. Wait TD and raise pin 16 to VCCP and pins 2-7, 10 to VIHP. At the same time, the SEL input (pin 9) is set to either VIHP or VIL in order to select the desired polarity of the input which is to be programmed. When SEL is at VIHP, the input will be programmed high true. When SEL is at VILH, the input will be programmed low true.

- c. Wait TD and pulse the input to be programmed to ground for PWP milliseconds. It should be noted that only one input should be programmed at a time.
- d. After a delay TD, return pin 16 to VCCV and pins 2-7, 10 to VIHV.
- e. Repeat steps b), c), and d) until pins 2-7 have been programmed with the appropriate polarity.
- f. When all inputs have been programmed as explained above, wait TD and return the programming enable pin (pin 1) to VIL.

Fuse Integrity Testing

- Correct programming of the device should be verified by applying test vectors to the input pins.
- b. Fuse integrity is tested by applying VCC to the device and measuring the static power consumption of the device. With all inputs at VCC or GND and the output pins unloaded, the measured ICCSB of the device should be less than 50 μA at VCC = 5V and T = 25°C. This guarantees that all fuses have been blown to a final state which is not marginal and will not create a reliability problem over the life of the device. NOTE: Any device which fails this test should be rejected even if it passes functional testing in order to ensure no future reliability problems associated with marginally blown fuses.

IMPORTANT: All six inputs <u>must</u> be programmed regardless of desired high or low input polarity. The advanced design of the fuse select circuitry (Patent Pending) provides for ultra-low post programming ICCSB and requires that one fuse on each input be programmed.

Programming Waveforms

